

UNITED STATES PATENT DOCUMENTS					
EXAMINER'S INITIALS	CITE NO.	PATENT NUMBER	ISSUE DATE MM-DD-YYYY	FIRST NAMED INVENTOR	

FOREIGN PATENT DOCUMENTS					
EXAMINER'S INITIALS	CITE NO.	DOCUMENT NUMBER	COUNTRY OR REGION	DATE OF PUBLICATION MM-DD-YYYY	FIRST NAMED INVENTOR OR APPLICANT
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		OTHER PRIOR ART - NON-PATENT DOCUMENTS
EXAMINER' S INITIALS	NO	Include name of the author (in Capital Letters), title of the article (when appropriate), title of the item(book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published

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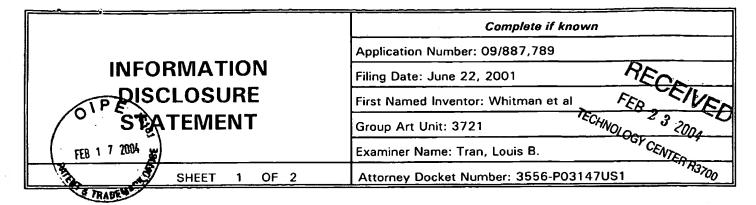
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EXAMINER'S	(221)	DATE CONSIDERED	5/24/04
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		UNITED STA	ATES PATENT DOCUM	ENTS
EXAMINER'S INITIALS	CITE NO.	PATENT NUMBER	ISSUE DATE MM-DD-YYYY	FIRST NAMED INVENTOR
UT		5,667,517	09/16/1997	Hooven
		5,954,259	09/21/1999	Viola
		5,868,760	09/09/1999	McGuckin
		5,653,374	08/05/1997	Young
		5,433,721	07/18/1995	Hooven
		6,165,169	10/12/2000	Panescu, et al.
		5,772,597	10/06/1998	Goldberger, et al.
<b>V</b>	-	5,993,454	11/30/1999	Longo
NOT WASIDERED	4 -	0634,144	01/18/1995	Ethicon
Á	<del>-</del>	6119913	09/19/2000	Main, et al.
1		5529235	6/25/1996	Boiarski, et al.
		5609560	03/11/1997	Ichikawa, et al.
		5617857	04/08/1997	Chader, et al.
		5993454	11/30/1999	Longo
		6059719	05/09/2000	Yamamoto, et al.
7		6434507	08/13/2002	Clayton, et al.

		FO	REIGN PATENT	DOCUMENTS	
EXAMINER'S INITIALS	CITE NO.	DOCUMENT NUMBER	COUNTRY OR REGION	DATE OF PUBLICATION MM-DD-YYYY	FIRST NAMED INVENTOR OR APPLICANT
V		99/58076	WO	11/18/1999	
A		92/16141	WO	10/01/1992	
11		2044108	GB	10/15/1990	
13		0116220	EP	0/22/1984	

EXAMINER'S DATE CONSIDERED S/29/04					
	EXAMINER'S SIGNATURE	w	DATE CONSIDERED	5	

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INFORMATION

DISCLOSURE

First Named Inventor: Whitman et al

Group Art Unit: 3721

Examiner Name: Tran, Louis B.

SHEET 2 OF 2

Complete if known

Application Number: 09/887,789

Filing Date: June 22, 2001

First Named Inventor: Whitman et al

Group Art Unit: 3721

Examiner Name: Tran, Louis B.

it	0156774	EP	10/02/1985	RECEIVED
(	0399701	EP	11/28/1990	FED
	0552050	EP	07/21/1993	7 2 3 2004
	7711347	NL	04/19/1979	TECHNOLOGY CENTER B3700
	3300768	DE	07/19/1984	
	2180455	GB	04/01/1987	
	0216532	EP	04/01/1987	
	90/05491	WO	05/31/1990	
	0593920	EP	04/27/1994	
	0539762	EP	10/05/1992	
	0621006	EP	03/22/1994	
V	93/08754	WO	05/13/1993	

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